

Notice of References Cited	Application/Control No. 10/500,893		Applicant(s)/Patent Under Reexamination OYAKE ET AL.	
	Examiner Anna L. Verderame		Art Unit 1756	Page 1 of 1

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*	B	US-2002/0105103	08-2002	Kerfeld, Donald J.	264/40.1
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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